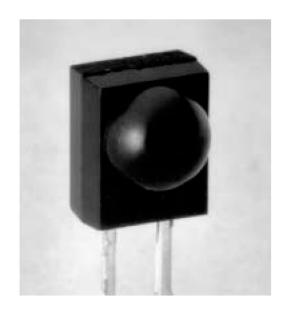
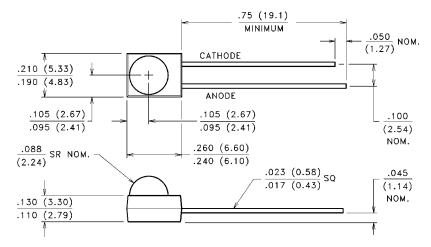
VTP Process Photodiodes

VTP7840H



PACKAGE DIMENSIONS inch (mm)



CASE 51 LENSED SIDELOOKER CHIP ACTIVE AREA: .0082 in² (5.27 mm²)

PRODUCT DESCRIPTION

Planar silicon photodiode in a transfer molded, large lensed sidelooker package. The dark package material filters out visible light but passes infrared. These diodes exhibit low dark current under reverse bias and fast speed of response.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature: -40°C to 85°C Operating Temperature: -40°C to 85°C

RoHS Compliant



ELECTRO-OPTICAL CHARACTERISTICS @ 25°C (See also VTP curves, pages 45-46)

| SYMBOL | CHARACTERISTIC | TEST CONDITIONS | VTP7840H | | | UNITS |
|------------------------|---|--------------------|--------------------------------|------|------|---------|
| | | | Min. | Тур. | Max. | 1 UNITS |
| I _{SC} | Short Circuit Current | H = 100 fc, 2850 K | 50 | 70 | | μA |
| TC I _{SC} | I _{SC} Temperature Coefficient | 2850 K | | .20 | | %/°C |
| V_{OC} | Open Circuit Voltage | H = 100 fc, 2850 K | | 325 | | mV |
| TC V _{OC} | V _{OC} Temperature Coefficient | 2850 K | | -2.0 | | |
| l _D | Dark Current | H = 0, VR = 10 V | | | 20 | nA |
| R _{SH} | Shunt Resistance | H = 0, V = 10 mV | | 0.25 | | GΩ |
| С | Junction Capacitance | H = 0, V = 3 V | | | 40 | pF |
| S _R | Sensitivity | @ Peak | | .55 | | A/W |
| $\lambda_{ m range}$ | Spectral Application Range | | 725 | | 1150 | nm |
| $\lambda_{\mathbf{p}}$ | Spectral Response - Peak | | | 925 | | nm |
| V_{BR} | Forward Voltage | @ 10 mA | | 1.0 | | V |
| θ _{1/2} | Angular Resp 50% Resp. Pt. | | | ±48 | | Degrees |
| NEP | Noise Equivalent Power | | 5.3 x 10 ⁻¹⁴ (Typ.) | | | W ∕ √Hz |
| D* | Specific Detectivity | | 5.1 x 10 ¹² (Typ.) | | | cm√Hz/W |

VTP Process Photodiodes

VTP PROCESS FAST RESPONSE, HIGH DARK RESISTANCE

FEATURES

- · Visible to enhanced IR spectral range
- Integral visible rejection filters available
- Response @ 940 nm, 0.60 A/W, typical
- -1 to 2% linearity over 7 to 9 decades
- Low dark currents
- High shunt resistance
- High reverse voltage rating
- Low capacitance

PRODUCT DESCRIPTION

Photodiodes in this series have been designed for low junction capacitance. The lower the capacitance, the faster the response of the diode. Also, speed can be further increased by reverse biasing the diodes which lowers the capacitance even more.

These diodes have excellent response in the IR region and are well matched to IR LEDs. Responsivity is categorized at 940 nm (GaAs LED). Some diodes are available in packages which incorporate a visible rejection filter effectively blocking any light below 700 nm.

Diodes made with the VTP process are suitable for operation under reverse bias conditions but may be used in the photovoltaic mode. Typical reverse breakdown voltages are around 140 V. Low dark currents under reverse bias are also a feature of this series.